



# SLOVENSKI STANDARD

## SIST EN 62493:2015

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Nadomešča:  
SIST EN 62493:2010

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### Ocenjevanje opreme za razsvetljavo z vidika izpostavljenosti ljudi elektromagnetnim poljem

Assessment of lighting equipment related to human exposure to electromagnetic fields

Beurteilung von Beleuchtungseinrichtungen bezüglich der Exposition von Personen  
gegenüber elektromagnetischen Feldern

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Évaluation d'un équipement d'éclairage relativement à l'exposition humaine aux champs  
électromagnétiques

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EUROPEAN STANDARD

**EN 62493**

NORME EUROPÉENNE

EUROPÄISCHE NORM

May 2015

ICS 29.020; 29.140

Supersedes EN 62493:2010

English Version

## Assessment of lighting equipment related to human exposure to electromagnetic Field (IEC 62493:2015)

Évaluation d'un équipement d'éclairage relativement à  
l'exposition humaine aux champs électromagnétiques  
(IEC 62493:2015)

Beurteilung von Beleuchtungseinrichtungen bezüglich der  
Exposition von Personen gegenüber elektromagnetischen  
Feldern  
(IEC 62493:2015)

This European Standard was approved by CENELEC on 2015-04-14. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the CEN-CENELEC Management Centre or to any CENELEC member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the CEN-CENELEC Management Centre has the same status as the official versions.

SIST EN 62493:2015

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European Committee for Electrotechnical Standardization  
Comité Européen de Normalisation Electrotechnique  
Europäisches Komitee für Elektrotechnische Normung

**CEN-CENELEC Management Centre: Avenue Marnix 17, B-1000 Brussels**

## Foreword

The text of document 34/222/FDIS, future edition 2 of IEC 62493, prepared by IEC/TC 34 "Lamps and related equipment" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 62493:2015.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2016-01-14
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2018-04-14

This document supersedes EN 62493:2010.

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## Endorsement notice

The text of the International Standard IEC 62493:2015 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

CISPR 15:2013	NOTE	Harmonized as EN 55015:2013 (not modified).
CISPR 16-1-2	NOTE	Harmonized as EN 55016-1-2.
CISPR 16-4-2:2003	NOTE	Harmonized as EN 55016-4-2:2004 <sup>1)</sup> (not modified).
IEC 62226-2-1:2004	NOTE	Harmonized as EN 62226-2-1:2005 (not modified).

<sup>1)</sup> Superseded by EN 55016-4-2:2011 (CISPR 16-4-2:2011).

## Annex ZA (normative)

### Normative references to international publications with their corresponding European publications

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 When an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: [www.cenelec.eu](http://www.cenelec.eu)

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 62209-2	2010	Human exposure to radio frequency fields from hand-held and body-mounted wireless communication devices - Human models, instrumentation, and procedures - Part 2: Procedure to determine the specific absorption rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)	EN 62209-2	2010
IEC 62232	2011	Determination of RF field strength and SAR in the vicinity of radiocommunication base stations for the purpose of evaluating human exposure	-	-
IEC 62311 (mod)	2007	Assessment of electronic and electrical equipment related to human exposure restrictions for electromagnetic fields (0 Hz - 300 GHz)	EN 62311	2008
IEC 62479 (mod)	2010	Assessment of the compliance of low power electronic and electrical equipment with the basic restrictions related to human exposure to electromagnetic fields (10 MHz to 300 GHz)	EN 62479	2010
CISPR 16-1-1	-	Specification for radio disturbance and immunity measuring apparatus and methods - Part 1-1: Radio disturbance and immunity measuring apparatus - Measuring apparatus	EN 55016-1-1	-

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IEC 62493

Edition 2.0 2015-03

# INTERNATIONAL STANDARD

## NORME INTERNATIONALE



**Assessment of lighting equipment related to human exposure to electromagnetic field**

**(standards.iteh.ai)**

**Évaluation d'un équipement d'éclairage relativement à l'exposition humaine aux champs électromagnétiques**

INTERNATIONAL  
ELECTROTECHNICAL  
COMMISSION

COMMISSION  
ELECTROTECHNIQUE  
INTERNATIONALE

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## INTERNATIONAL ELECTROTECHNICAL COMMISSION

**ASSESSMENT OF LIGHTING EQUIPMENT RELATED  
TO HUMAN EXPOSURE TO ELECTROMAGNETIC FIELDS**

## FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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International Standard IEC 62493 has been prepared by IEC technical committee 34: Lamps and related equipment.

This second edition cancels and replaces the first edition published in 2009. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) identification of lighting product types deemed to comply with the standard without the need for test;
- b) deletion of the need for CISPR-15-compliance as a prerequisite for IEC 62493 compliance;
- c) inclusion of the consequences of the ICNIRP 2010 guidelines for (up to 100 kHz);
- d) adding some guidance to the Van der Hoofden test head method to improve reproducibility of results;
- e) inclusion of compliance demonstration method for products having intentional radiators.

The text of this standard is based on the following documents:

FDIS	Report on voting
34/222/FDIS	34/228/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62493 series, published under the general title *Assessment of lighting equipment related to human exposure to electromagnetic fields*, can be found on the IEC website.

The exposure limits given in Annex C (informative) are for information only; they do not comprise an exhaustive list and are valid only in certain regions of the world. It is the responsibility of users of this standard to ensure that they use the current version of the limit values specified by the applicable national authorities.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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## INTRODUCTION

This International Standard establishes a suitable evaluation method for the influence of the electromagnetic fields in the space around the equipment mentioned in the scope, and defines standardized operating conditions and measurement distances.

This standard is designed to assess, by measurements and/or calculations, electromagnetic (EM) fields and their potential effect on the human body by reference to exposure levels of the general public given by ICNIRP:1998 [1]<sup>1</sup>, ICNIRP 2010 [2], IEEE C95.1:2005 [3] and IEEE C95.6:2002 [4]. The exposure levels with which to comply are basic restrictions (both ICNIRP- and IEEE-based).

Based on the lighting equipment operating properties, the frequency range of the applicable basic restrictions can be limited as follows:

- internal electric field between 20 kHz and 10 MHz;
- specific absorption rate (SAR) between 100 kHz and 300 MHz;
- power density is outside the scope.

NOTE Operating frequencies of lighting equipment are higher than 20 kHz to avoid audible noise and infrared interference. Frequency contributions above 300 MHz can be neglected.

This standard is not meant to supplant definitions and procedures specified in exposure standards, but it is aimed at supplementing the procedure already specified for compliance with exposure.

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<sup>1</sup> Numbers in square brackets refer to the Bibliography.

## ASSESSMENT OF LIGHTING EQUIPMENT RELATED TO HUMAN EXPOSURE TO ELECTROMAGNETIC FIELDS

### 1 Scope

This International Standard applies to the assessment of lighting equipment related to human exposure to electromagnetic fields. The assessment consists of the induced internal electric field for frequencies from 20 kHz to 10 MHz and the specific absorption rate (SAR) for frequencies from 100 kHz to 300 MHz around lighting equipment.

Included in the scope of this standard are:

- all lighting equipment with a primary function of generating and/or distributing light intended for illumination purposes, and intended either for connection to the low voltage electricity supply or for battery operation; used indoor and/or outdoor;
- lighting part of multi-function equipment where one of the primary functions of this is illumination;
- independent auxiliaries exclusively for the use with lighting equipment;
- lighting equipment including intentional radiators for wireless communication or control.

Excluded from the scope of this standard are:

- lighting equipment for aircraft and airfields;
- lighting equipment for road vehicles; (except lighting used for the illumination of passenger compartments in public transport)
- lighting equipment for agriculture; [SIST EN 62493:2015](https://standards.iteh.ai/catalog/standards/sist/5db46564-8d53-4e51-9b37-83ad7b33c01/sist-en-62493-2015)
- lighting equipment for boats/vessels; <https://standards.iteh.ai/catalog/standards/sist/5db46564-8d53-4e51-9b37-83ad7b33c01/sist-en-62493-2015>
- photocopiers, slide projectors;
- apparatus for which the requirements of electromagnetic fields are explicitly formulated in other IEC standards.

NOTE The methods described in this standard are not suitable for comparing the fields from different lighting equipment.

This standard does not apply to built-in components for luminaires such as electronic controlgear.

### 2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 62209-2:2010, *Human exposure to radio frequency fields from hand-held and body-mounted wireless communication devices – Human models, instrumentation, and procedures – Part 2: Procedure to determine the specific absorption rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)*

IEC 62232:2011, *Determination of RF field strength and SAR in the vicinity of radiocommunication base stations for the purpose of evaluating human exposure*

IEC 62311:2007, *Assessment of electronic and electrical equipment related to human exposure restrictions for electromagnetic fields (0 Hz – 300 GHz)*